

Notice of References Cited

Application/Control No.

10/028,778

Applicant(s)/Patent Under

Reexamination

TANAKA ET AL.

Examiner

FAZLI ERDEM

Art Unit

2826

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,096,572	08-2000	Nakamura, Kenichi	438/30
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	C	US-			
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	K	US-			
	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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